Conductivity and A tom ic Structure of Isolated M ultiwalled Carbon N anotubes

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> We report associated high resolution transmission electron microscopy (HRTEM) and transport m easurem ents on a series of isolated multiwalled carbon nanotubes. HRTEM observations, by revealing relevant structural features of the tubes, shed som e light on the variety of observed transport behaviors, from sem iconducting to quasi-m etallic type. Non 0 hm ic behavior is observed for certain samples which exhibit "bamboo like" structural defects. The resistance of the most conducting sample, measured down to 20 mK, exhibits a pronounced maximum at 0.6 K and strong positive m agnetoresistance.

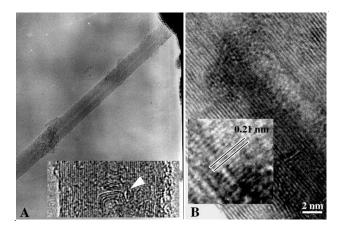


FIG.1. Transm ission electron m icroscopy on studied sam ples: A -Partial view of a connected nanotube (only one m etallic pad is visible). Note the presence of some carbonaceous material visible on the outer surface of the nanotube. It is mainly due to electron damage during observation. Inset: HRTEM of a bam boo defect. B-HRTEM picture of Sn2 tube showing evidence of ordered stacking of non helical graphite shells.

Carbon nanotubes discovered by Iijim a [1] are quite unusual objects which, apparently, have no analogs in the solid state. A coording to theoretical predictions [2], a single graphite layer wrapped into a cylinder, can be a metal or a sem iconductor depending on its diameter and helicity. Due to the peculiarity of the Ferm i surface of 2D G raphite which is reduced to a set of discrete points $[\beta]$, there are only two conducting channels in a shell independently of its diam eter. Thus, single walled nanotubes (SW NT), constitute in principle ideal candidates for the study of electronic transport at 1D . How ever they are di cult to isolate and m anipulate for transport properties. The experim ent by Tans et al. [4] show ing evidence of single electron tunneling in an isolated single-wall nanotube deposited on a silicon substrate is a

rst fundam ental step in this direction. How ever the non

m etallic character of the electrical contacts in that experim ent did not allow direct investigation of transport. On the other hand multiwalled nanotubes [5] are easier to manipulate. Electron microscopy investigations show that they generally consist of shells of di erent helicity. That is, such a nanotube is a solid body in which one atom ic layer can be a m etal and another a sem iconductor. Transport m easurem ents started in 1995, when som e of us succeeded in m easuring the conductivity of an individualnanotube [6]. Then, severalworks on this problem were quickly reported [7{9]. In particular Ebessen et al. [9] have system atically studied the electrical properties of a large num ber of nanotubes. It was found that "each multishell nanotube has unique conductivity properties". The authors also suggested that the di erence in electric properties is due to the di erence of the nanotubes structure. However, even the inner diam eter or the number of shells in these nanotubes were unknown (this is also pertinent to works described in [7,8]). It seem ed obvious that a detailed investigation of the nanotubes structure would contribute to the understanding of nanotubes electric properties.

In this letter, we report the results of simultaneous investigations of the electric properties and structure of nanotubes in the transm ission electron m icroscope. The technique used for isolating an individual nanotube is qualitatively di erent from the other studies [7{9]. It allows studying in HRTEM the structure of the nanotube. The method consists in the following: a focused laser beam "shakes o " a nanotube from the target onto a sample with a Si_3N_4 membrane covered with a metal Im [10,11]. A submicron width slit about 100 m in length has previously been cut in the membrane by focused ion beam; the nanotube connects the edges of the slit see q.1 and shorts the electric circuit whose resistance was over 1G before the nanotube was "shaken o ". In the following we successively discuss electron microscopy observations and transport m easurem ents on a fam ily of tubes indexed as Au_N , Sn_N , Bi_N depending on the nature of the used m etal contact.

TABLE I. Resistance and structure of various nanotubes. N ote that the value of the resistance at 100K is m ore adequate to characterize the transport type of the sam ple than the value at room tem perature.

Sample	in ; out	# of	L	Bam boo	R ()	R ()	Т уре
nam e	(nm)	shells	(m)	defects	293K	100K	
Au1	25 , 7	26	2.1	No	1:0 10°	1	1 _A
Sn2	40,3	55	0.33	No	2:1 10 ⁴	1	1_{A}
Sn5	25,5	29	0.45	Yes	2:5 10 ⁶	1	1 _A
Au2	16,5	16	0.36	Yes	6 : 7 10 ⁵	10 ⁸	1 _B
Sn10	7,2	7	0.35	Yes	5 : 8 10 ⁶	5 10 ⁸	1 _B
Sn11	13,7	9	0.17	Yes	1 : 8 10 ⁶	6 10 ⁷	1 _B
Bi4	12,4	11	0.4	Yes	2 : 8 10 ⁴	3 : 4 10 ⁴	2
Au3	25,3	29	0.17	No	1 : 9 10 ³	8 10 ³	2
Au4	26,5	31	0.33	No	2 : 0 10 ⁵	2210 ⁶	2

The high resolution electron m icroscope (HRTEM) is a powerful tool to visualize the atom arrangem ent in solids. In the case of carbon nanotubes, the observed contrast can easily be related to the graphitic structure. G raphite layers ((002) lattice planes), when parallel to the electron beam i.e. in the Bragg di raction conditions, are seen as black and white fringes corresponding to the projection of atom ic positions. A carbon nanotube is therefore seen as a set of fringes parallel to the tube axis, generated by the sectors of the coaxial curved graphite sheets which lie parallel to the beam . Like in graphite, the distance between the layers is approxim ately 3.4 A.W e have used such pictures to estimate the inner and external tube diam eters and the num ber of layers com posing the nanotube. The structural parameters concerning the whole set of investigated individual tubes are listed in table 1. We have also con med that the metal from the contact does not wet the internal hollow of the nanotube.

A nother structural parameter is the helicity of the layers, i.e. the way the carbon hexagons paving the graphite sheet are oriented with respect to the tube axis. In non helical tubes, the hexagons in two sectors diam etrically opposed are parallel. As a result of the hexagonal lattice sym metry, the contrast in the areas with graphite planes perpendicular to the electron beam is composed of 3 fam ilies of parallel fringes arranged in a three fold sym m etry pattern. The distance between these fringes is 2.1 A and one fam ily of fringes is either perpendicular to the tube axis (zig-zag tubes) or parallel to the tube axis (arm chair tubes). As an example, we show in g.1B a high resolution in age of the tube constituting Sn2 sample. In this case, one fam ily of fringes is more obvious than both others. The fringes are perpendicular to the tube axis indicating that the cylinders con guration is zig-zag like. This picture according to simulations by Zhang et al. [12] is a strong indication for a graphite like stacking of most of the the nanotube shells. M ost investigated nanotubes

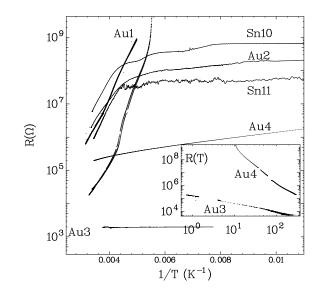


FIG.2. High temperature resistance (on sem i-logarithm ic scale) of the tubes, showing evidence of sem iconducting behavior for most of them. Inset: Temperature dependence on a Log-Log scale of the resistance of Au4 and Au3 showing evidence of power law increase at low temperature.

cannot be described only as perfect sets of coaxial cylinders, but exhibit defects which can a left the transport mechanisms. In particular a defect so called bamboo defect in the literature [13], has been identified in many cases: the inner shells of the nanotube are interrupted and separated by fullerenic sem i-spheres while the outer shells remain continuous, (see g.1A). The presence of such defects is indicated in table 1. We will see that the presence of these defects a lects transport properties when there exists a possibility of conduction between the outer and inner shells of the tube.

C oncerning transport properties twom ain types of behavior have been observed: sem i-conducting, (type 1_A , 1_B) and quasi-m etallic, (type2) as depicted below:

M ost samples belong to type 1. They exhibit a semiconducting behavior below 300 K , with exponentially activated temperature dependence of the resistance, (see

g 2). Typical gaps values lie between 2000 and 3000 K, sim ilar to values obtained in am orphous graphite [14]. Note how ever, that the room temperature values of the e ective resistivities, estimated from length and section of the tubes $_{\rm eff}$ = RS=L, are all below 1 cm which is orders of magnitude smaller than the typical values obtained for am orphous graphite. For some of these tubes (typel_B), a saturation of the resistance around 10⁸ is observed below 100K. It is striking that all these tubes contain one "bamboo" defect. These samples are also characterized by their strongly non linear I V characteristics below 100 K, see g.3. In most cases the dI=dV curves are not symmetrical in V;+V and also exhibit hysteresis and telegraphic noise only for one particular

voltage sign. The typical voltage scale for the non-linear behavior is of the order of few tenths of volts. At 4.2K and below the di erential conductance exhibits som e narrow peaks characteristic of a C oulom b blockade stair-case like behavior (width of the order of 10m V). For particular voltage values, telegraphic noise could also be recorded. The characteristic time scales are of the order of the m s at 77K and 1000s below 1K.

A few tubes (Au4, Au3 and Bi5) belong to type 2 and exhibit a "quasi-m etallic" behavior. Their resistances increase more slowly than exponentially at low temperature, varying approximatively like $1=T^{\times}$ (see g2 with x = 0.5 for Au3 and x = 2 for Au4, a lower increase was observed for B i5. W e never see any increase of resistance at high tem perature sim ilar to what is observed in "bulk" sam ples of SW NT [15]. Note how ever that this type of true "m etallic" behavior has only been recorded so far in "bulk" sam ples or ropes of SW NT and has never been reported for isolated nanotubes. On the Au3 sample we could also perform very low tem perature transport m easurements, shown in g.4. The R (T) curve exhibits a broad maximum around 0.6 K. The amplitude and position of this maximum varies drastically with the magnitude of magnetic eld applied perpendicularly to the tube axis. It shifts to lower tem perature with increasing magnetic eld and reaches higher resistance values. A coordingly, one observes a large positive magneto-resistance approximatively linear in magnetic eld (with a 50% increase for an applied eld of 4T.) To our know ledge it is the rst time that such remarkable features have been observed in the resistance measurements of nanotubes. These ndings are in contrast with those of Langer et al. [7] who had m easured negative m agnetoresistance, which could be interpreted as a weak localization e ect.

One in portant issue for understanding transport properties of these nanotubes is the separation between the contribution of the most external shell, which is the only one directly connected to the m etallic pads, and the possible contributions of internal shells. This is determ ined by the ratio = $R_{ext}=R_t$ between the resistance of this external shell and the resistance connecting this shell to internal shells. The combination of HRTEM observations and transport m easurem ents suggests that << 1 for type 1_A and type 2 nanotubes. One convincing example is the Sn2 sample: it contains 60 shells which, according to HRTEM observations, are arranged for most of them in a nearly perfect m etallic graphite type of order. However the tem perature dependence of its resistance indicates a sem iconducting behavior. These two results can be reconciled if transport takes place in the external shell of the tube and if there is no possibility of conduction through internal metallic shells. Unfortunately, we do not have any indication whether sem iconducting behavior is related to the helical structure of the tube external shell or to structural disorder in this shell.

The situation is di erent for type l_B samples, where

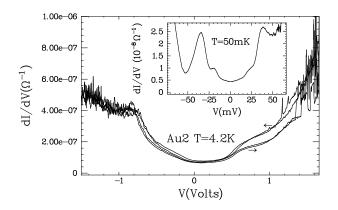


FIG.3. Non linear transport in Au2 on a wide voltage scale and inset showing narrow peaks at low temperature. These measurements were done by applying a small voltage modulation superimposed on the dc voltage.

gures 2 and 3 indicate a residual tunneling conductivity at low temperature. A possible explanation of these ndings could be tunneling on a metallic inner shell of the tube, behaving as a Coulom b island, separated from the metallic pads by external shells which are insulating at low temperature but however o er the possibility of electron transfer through high but nite tunneling resistance Rt. HRTEM observations reveal a complex situation with the existence of "bam boo" like defects It is more reasonable to assume that these nanotubes contain 2 distinct m etallic islands and eventually 3 tunnel junctions. The capacitance of such junctions of typically 10nm dimensions is of the order of 10¹⁹ F. On the other hand the capacitance of a metallic layer of length 100nm and diam eter 10 nm is of the order of 3 10 17 F . It corresponds to charging energies of respectively 1 eV and 30 m eV , i.e. which are compatible with the voltage scales of the features observed in q.3 on the non linear I V characteristics of these systems. The existence of telegraphic noise is related to the great sensitivity of the conductance of these junctions to structural defects which are still mobile at low tem perature for speci c values of dc polarization of the sam ple. Note also that the hysteresis in these I V curves observed only for positive values of voltages cannot be of therm all origin and may be due to some electro-mechanicale ect. We nally note that bam boo defects are only relevant for these 1_B type tubes for which internal shells play an important role in low tem perature transport properties (>> 1). They also exist in some type 1_A and type 2 samples but we do not think that they a ect their transport properties which are mainly determ ined by the outer shell (<< 1).

C oncerning type 2 sam ples, it is interesting to com pare our results with the power-law increase of the low tem – perature resistance predicted theoretically in nanotubes as a manifestation of electron-electron interactions on their transport properties [16]. M ore generally it is the

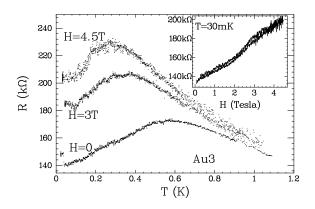


FIG.4. Low temperature resistance on Au3 sample for several values of magnetic eld. Inset: magnetoresistance at 30m K. The measurements were done with a ac current of 40p A at 30 Hz.

expected behavior in a 1D conductor whose Ferm i liguid behavior is unstable against the e ect of electronelectron interactions [17]. The power law exponent is not universal and can be strongly a ected by disorder [18]. The most striking result of this work concerns the low tem perature anomaly in the resistance of Au3 and its magnetic eld dependence. W e cannot exclude a superconducting uctuation but the absence of rounding of the anomaly with magnetic eld does not comfort this hypothesis. Another possibility could be a dimensional crossover as observed in organic conductors [19]. It would occur when the tem perature is of the order of the coupling between the shells. The magnetic eld, by con ning back the electrons in a given shell, would then be responsible of the shift of this crossover to lower tem perature. Finally we want to emphasize that contrary to previous studies on deposited nanotubes, we are working on suspended structures. This o ers the possibility of special vibration modes on the samples (standing waves whose wave-lengths are determined by the distance between the electrical contacts). It is notew orthy that the fundam entalm ode of energy $E_0 = hv_s = L$ where v_s is the sound velocity along the tube (of the order of 10^3 m =s) and L = 100nm corresponds to a temperature of the order of 1K, close to the position of the maximum observed in the resistance of Au3 sam ple. As suggested by the work of A jiki and Ando [21], applying a transverse m agnetic

eld on a nanotube is also expected to produce a lattice distortion and huge positive magnetoresistance due to the increase of the gap with magnetic eld. These considerations suggest, according to recent theoretical predictions [20] a huge sensitivity of transport properties of nanotubes to mechanical stress or distortions and deserve further experim ental investigations.

In conclusion simultaneous HTREM and resistance m easurements performed on the same samples, highlight the importance of internal structural defects when com - pared to the helicity parameters, in the mechanism of electron conductivity. We have also shown that the outer shell determ ines the resistance form ost insulating or conducting tubes, even if it is not yet possible to investigate speci cally the structure of this shell. Speci c "bam boo" type defects could be identi ed which are fundamental for the understanding of intermediate behavior, where internal shells contribute to electronic transport through tunnel junctions. We have nally demonstrated that measuring transport properties of nanotubes is specially interesting at very low temperatures with the existence of an anomaly in the temperature dependence, highly sensitive to the strength of magnetic edd.

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- [1] S. Lijim a, Nature 354, 56 (1991).
- [2] JW . M intm ire, B.I. Dunlap, C.T. W hite, Phys. Rev. Lett. 68, 631 (1992); N. Ham ada, A. Sawada, A. Oshiyam a, Phys. Rev. Lett. 68, 1579 (1992); R. Saito et al, Appl. Phys. Lett.60, 2204 (1992).
- [3] P.R.W allace, PhysRev.71, 622 (1947).
- [4] S.J.Tans, et al., Nature 386,474 (1997)
- [5] M. Liu., J.M. Cowley, Ultram icroscopy 53, 333 (1994).
- [6] A.Yu.Kasum ov, I.I.Khodos, PM.A jayan, C.Colliex, Proceeding of International Workshop "Fullerenes and Atom ic Clusters" (1995 St.Petersberg, Russia).
- [7] L.Langer et al, Phys. Rev. Lett. 76, 479 (1996).
- [8] H. Dai, E.W. Wong, C.M. Lieber, Science 272,523 (1996).
- [9] T.W. Ebessen et al., Nature 382, 54 (1996).
- [10] A Yu.K asum ov, I.I.K hodos, P M .A jayan and C.Colliex, Europhys.Lett. 34, 429 (1996).
- [11] A.Yu.Kasum ov et al, Phys.Rev.Lett. 75, 4286 (1995).
- [12] X F. Zhang et al., J. of Crystal G row th 130, 368 (1993).
- [13] S.Lijim a, P.M. A jayan, T. Ichihashi, PhysRevLett. 69,3100 (1992).
- [14] J. Robertson, Advances in Physics, 35, 317 (1986).
- [15] JE.Fisher et al, PhysRev.B 55, 4921 (1997).
- [16] L. Balents and M PA. Fisher, PhysRev. B 55,11973 (1997) and preprint cond-m at/9708054 (1997).
- [17] H J.Schulz "M esoscopic quantum physics" E A kkem ans et al. Les H ouches proceedings, E lsevier (1995).
- [18] H M aurey and T G iam archiPhysRev B 51,10833 (1995).
- [19] K Benhia et al. PhysRevLett. 74, 5272 (1995).
- [20] C L.K ane and E L.M ele PhysRevLett. 78, 1932 (1997).
- [21] A jikiH .and T Ando, J.Phys.Soc.Japan 65,2976 (1996).